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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/780,410	MILLER ET AL.	
Examiner	Art Unit	
John T. Kwon	3747	

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Class	Subclass	Date	Examiner
701	112	6/9/2005	JK
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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east	6/9	//2005	JK	
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